#### January 2001

# FAIRCHILD

SEMICONDUCTOR IM

### Si4925DY

## Dual P-Channel, Logic Level, PowerTrench MOSFET

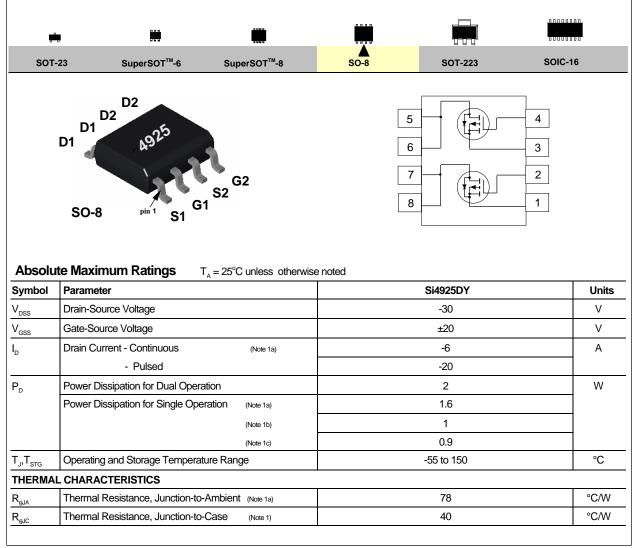
#### **General Description**

These P-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

These devices are well suited for notebook computer applications: load switching and power management, battery charging circuits, and DC/DC conversion.

#### Features

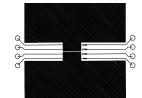
- $\begin{array}{c|c} \bullet & -6 \text{ A, } -30 \text{ V. } \text{R}_{\text{DS(ON)}} = 0.032 \ \Omega & @ \text{ V}_{\text{GS}} = -10 \text{ V,} \\ \text{R}_{\text{DS(ON)}} = 0.045 \ \Omega & @ \text{ V}_{\text{GS}} = -4.5 \text{ V.} \end{array}$
- Low gate charge (14.5nC typical).
- High performance trench technology for extremely low R<sub>DS(ON)</sub>.
- High power and current handling capability.



Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHAR	ACTERISTICS					•
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = -250 \mu A$	-30			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient	$I_{D}$ = -250 µA, Referenced to 25 °C		-21		mV/ºC
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{\rm DS} = -24 \text{ V}, \ V_{\rm GS} = 0 \text{ V}$			-1	μA
		$T_{J} = 55^{\circ}C$			-10	μA
	Gate - Body Leakage, Forward	$V_{GS} = 16 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
	Gate - Body Leakage, Reverse	$V_{gS} = -16 V, V_{DS} = 0 V$			-100	nA
	CTERISTICS (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{\rm DS} = V_{\rm GS}, \ I_{\rm D} = -250 \ \mu {\rm A}$	-1	-1.7	-3	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temp. Coefficient	$I_{\rm D}$ = 250 µA, Referenced to 25 °C		4		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{gg} = -10 \text{ V}, \text{ I}_{p} = -6 \text{ A}$		0.025	0.032	Ω
50(011)		T <sub>.1</sub> =125°C		0.033	0.051	
		$V_{gs} = -4.5 \text{ V}, \text{ I}_{p} = -5 \text{ A}$		0.034	0.045	
D(ON)	On-State Drain Current	$V_{GS} = -10 \text{ V}, V_{DS} = -5 \text{ V}$	-20			Α
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -10 \text{ V}, \text{ I}_{D} = -6 \text{ A}$		16		S
DYNAMIC	CHARACTERISTICS			•	•	
C <sub>iss</sub>	Input Capacitance	$V_{DS} = -15 V, V_{GS} = 0 V,$		1540		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		400		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			170		pF
SWITCHING	CHARACTERISTICS (Note 2)					
t <sub>D(on)</sub>	Turn - On Delay Time	V <sub>DS</sub> = -15 V, I <sub>D</sub> = -1 A		13	24	ns
ţ,	Turn - On Rise Time	$V_{\text{GEN}}$ = -10 V, $R_{\text{GEN}}$ = 6 $\Omega$		22	35	ns
t <sub>D(off)</sub>	Turn - Off Delay Time			47	75	ns
t <sub>r</sub>	Turn - Off Fall Time			18	30	ns
Q <sub>g</sub>	Total Gate Charge	$V_{\rm DS} = -10 \text{ V}, \ I_{\rm D} = -6 \text{ A},$		14.5	20	nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{GS}$ = -5 V		4		nC
Q <sub>gd</sub>	Gate-Drain Charge			5		nC
DRAIN-SOL	IRCE DIODE CHARACTERISTICS AND MAX	KIMUM RATINGS				
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current				-1.3	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	rward Voltage $V_{GS} = 0 \text{ V}, \text{ I}_{S} = -1.3 \text{ A} \text{ (Note 2)}$		-0.73	-1.2	V

Notes:

1. R<sub>BW</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R<sub>BW</sub> is guaranteed by design while R<sub>BW</sub> is determined by the user's board design.



a. 78°C/W on a 0.5 in<sup>2</sup> pad of 2oz copper.

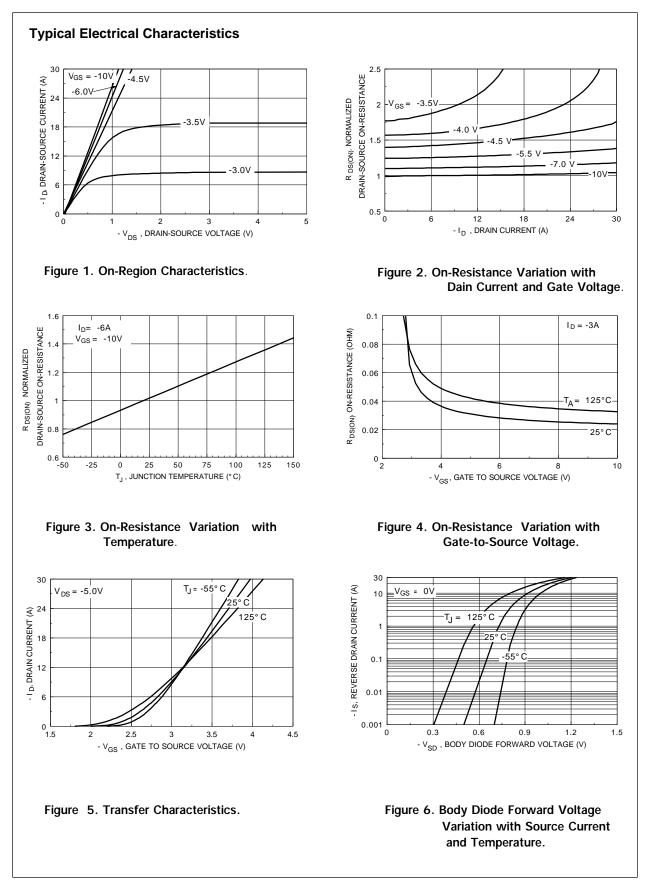


b. 125°C/W on a 0.02 in<sup>2</sup> pad of 2oz copper.

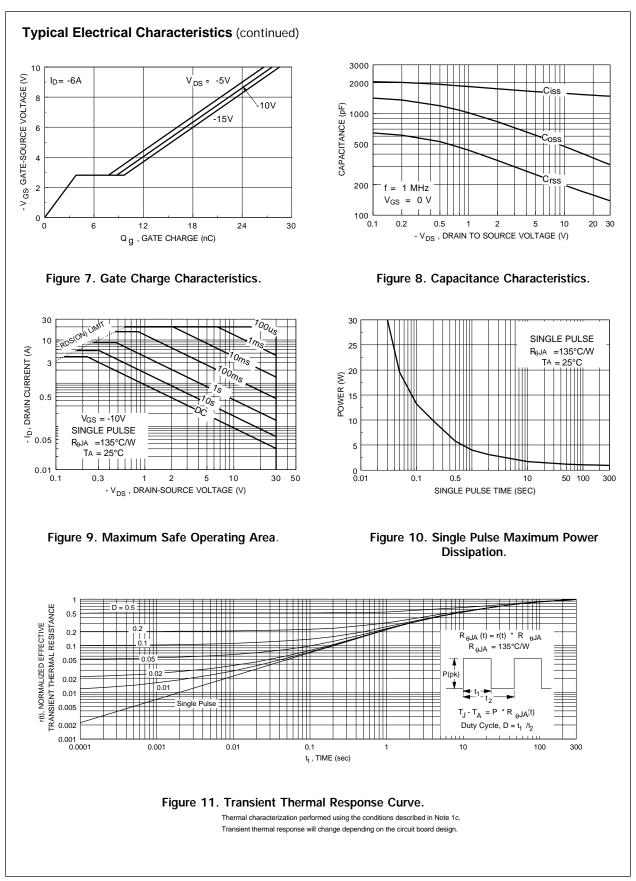
c. 135°C/W on a 0.003 in<sup>2</sup> pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\underline{<}$  300µs, Duty Cycle  $\underline{<}$  2.0%.



Si4925DY Rev.A



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